Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/330,034	MIN-CHEN ET AL.		
Examiner	Art Unit		
Hien D. Vu	2833		

SEARCHED					
Class	Subclass	Date	Examiner		
439	534,668, 669,686	1/8/1999	HV		
379	446	1/8/1999	HV		
Updated	Search	2/1/2006	HV		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			:	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Text Search Done	2/2/2006	HV	